

**Notice of References Cited**

Application/Control No.

10/554,222

Applicant(s)/Patent Under  
Reexamination  
MIYAMA ET AL.

Examiner

Alix Elizabeth Echelmeyer

Art Unit

1795

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-7,214,756	05-2007	Nomura et al.	528/30
*	B	US-2004/0197613	10-2004	Curlier et al.	429/014
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

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	N	WO03/041091	10-2003	WIPO	Nomura et al.	
	O	JP 2002-309016	10-2002	Japan	Honma et al.	
	P					
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	W	
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